9th VXD Belle II Workshop

Wednesday, 13 January 2016

DEPFET and System Tests - Main Conference Room (14:00 - 16:00)

  -Conveners: Christian Koffmane

time	[id] title	presenter
14:00	[11] Charge Collection of PXD9 DEPFETs	RICHTER, Rainer
14:20	[7] Status of probe card test preparations	BORONAT, Marca
14:35	[10] Noise Immunity Teststand at Saragoza	Dr ARTECHE, Fernando
14:55	[14] Detection of Communication Errors from ADC Curves	Mr SCHWENKER, Benjamin Mr WIEDUWILT, Philipp
15:10	[21] DHPT1.0/1.1 Hybrid 5 System Test	PASCHEN, Botho
15:25	[15] PXD9 Pilot Testing	KOFFMANE, Christian Mr MUELLER, Felix HAIDL, Jakob